

Notice of References Cited	Application/Control No. 10/729,796		Applicant(s)/Patent Under Reexamination KAPLAN, ADAM S.	
	Examiner Michael Pervan		Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0051392	03-2004	Badameh, Ziad	307/112
	B	US-			
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FOREIGN PATENT DOCUMENTS

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